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## Emittance Growth from Transient Coherent Synchrotron Radiation

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## Abstract

If the energies of the individual particles comprising a bunch change as the bunch traverses a bending system, even if it is achromatic, then betatron oscillations can be excited. Consequently, the transverse emittance of the bunch will grow as it moves downstream. Short bunches may be particularly susceptible to emission of coherent synchrotron radiation which can act back on the particles to change their energies and trajectories. Because a bend spans a well-defined length and angle, the bunch-excited wakefield and its effect back on the bunch are inherently transient. We outline a recently developed theory of this effect and apply it to example bending systems.

## 1. Introduction

When accelerated, a compact ensemble, or bunch, of relativistic charged particles radiates coherently at wavelengths comparable to or longer than the bunch length. This establishes an electromagnetic wake that acts back on the bunch and distorts it. For example, coherent synchrotron radiation (CSR) establishes an electromagnetic-field gradient along the bunch and causes the energies of the individual particles comprising the bunch to change by differing amounts as the bunch traverses a magnetic bend. In turn, even in a magnetic bending system that is achromatic, the transverse emittance of the bunch grows as it moves downstream.

CSR-induced beam degradation is of concern for any accelerator of short, high-charge bunches that incorporates magnetic bends in its transport system. This includes accelerator drivers for high-power free-electron lasers. For example, in the design of Jefferson Lab's high-power infrared FEL, or "IR Demo" [1], which incorporates a transport system to recirculate the electron beam back to the linac for energy recovery, potential beam degradation due to CSR motivated placing the wiggler directly after the linac rather than after the first recirculation bend, with a concomitant increase in the machine footprint. This exemplifies the impact of CSR on accelerator design and highlights the need for detailed understanding of the phenomenon.

## 2. Highlights of a Theory

In a recent paper [2], hereafter called Paper 1, we formulated an analytic theory of CSR. The theory

includes transient effects and an infinite parallel-plate model of the vacuum pipe, and it uses a rigid line charge as a model of the bunch. The calculation of the normalized transverse emittance includes a proper treatment of the transport lattice. Details of the calculations, and resulting analytic expressions for the radiated power and the normalized transverse emittance, appear in Paper 1.

A representative result of a calculation of the power radiated in the presence of the parallel plates is shown in Figure 1. The selected parameters correspond to a large vacuum chamber (having the characteristic dimension of the vacuum chamber planned for the IR Demo) and short bunch (also representative of that in the IR Demo). The

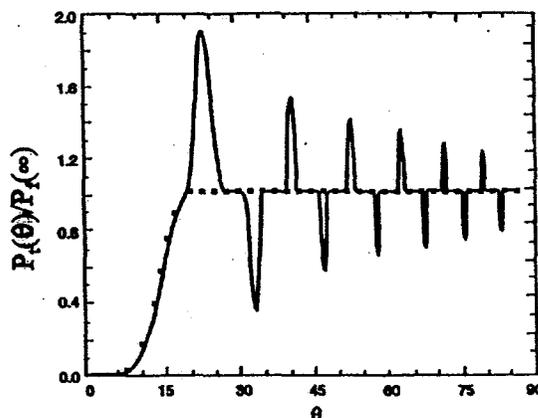


Fig. 1. The dotted curve denotes the transient free-space power  $P_r(\theta)/P_r(\infty)$  radiated by a bunch in a bend vs. bend angle  $\theta$ . The solid curve denotes the transient radiated power  $P_r(\theta)/P_r(\infty)$  in parallel conducting plates. Parameters are: 1 m bend radius, 40 MeV beam energy, 5 cm plate spacing, and 0.5 mm bunch length.

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localized transient peaks are due to the interaction of the bunch with its image charges generated by the parallel plates. A small vacuum chamber and long bunch gives rise to considerable shielding of the steady-state radiation (bend angle  $\theta \rightarrow \infty$ ), but this is not the situation illustrated in Figure 1, and so shielding is negligible there.

Inspection of Figure 1 reveals general qualitative aspects of the effect of CSR on transverse-emittance growth in the presence of conducting walls. First, in short bends, the existence of a formation length to reach steady state will cause the emittance growth to be less than that predicted from steady-state CSR. Second, in long bends, the transients will tend to average out and the steady-state radiation field will predominate.

### 3. Applications of the Theory

Paper 1 gives a recipe for calculating the transverse-emittance growth resulting from the CSR-induced electromagnetic field across the rigid-line bunch. The transverse emittance is  $\varepsilon = [\varepsilon_0^2 + (\Delta\varepsilon)^2]^{1/2}$ , with  $\varepsilon_0$  the initial emittance and  $\Delta\varepsilon$  the CSR-induced emittance growth. If the dominant effect is to change the energies of the individual particles as the bunch traverses a bend magnet, then  $\Delta\varepsilon \approx \gamma[(x^2)(\delta x^2)]^{1/2}$ , in which  $\gamma$  is the design energy,  $x$  is the transverse offset from the design orbit, and  $\delta x' = \Delta x' - \langle \Delta x' \rangle$ , where  $\Delta x'$  is the CSR-induced dispersive angle. The CSR-induced emittance growth scales proportionally to  $\gamma^{-1} I_p (R/\sigma)^{1/3}$ , where  $I_p$  is the peak current,  $R$  is the bend radius, and  $\sigma$  is the rms bunch length. It also scales proportionally to a time-dependent coefficient accounting for the transient behavior, and a bend-angle-dependent coefficient which scales as  $\theta^2$  for short bends and as  $\theta \sin\theta + \cos\theta - 1 \approx \theta \sin\theta$  for long bends.

We have applied the results of Paper 1 to calculate the emittance growth in bending subsystems of the IR Demo. The buncher chicane preceding the wiggler is comprised of four short magnets, as shown in Figure 2. A tracking code was used to calculate the bunch length at each magnet. The transport matrices of the lattice were used to propagate an electron through the chicane while using the CSR theory to calculate the electron position and energy offsets at the exit of each magnet assuming they are uncorrelated with respect to CSR. The final normalized emittance was then calculated using the results for the electron's final offset and angle. It was calculated to be about 7% higher than the nominal initial normalized emittance of 6.5 mm-mrad. By comparison, if a steady-state force had been assumed, the final emittance works out to be about 43% higher than the nominal initial emittance. This illustrates the beneficial consequence of the formation length in short bend magnets.

We also applied this procedure to the 180° bend magnet of the IR Demo's first recirculation bend. In this

case the steady-state force suffices for the calculation. According to particle-tracking results, the bunch length varies dramatically during transit. A rough estimate using a 1 mm representative average bunch length yields a dangerously large factor-of-two emittance growth.

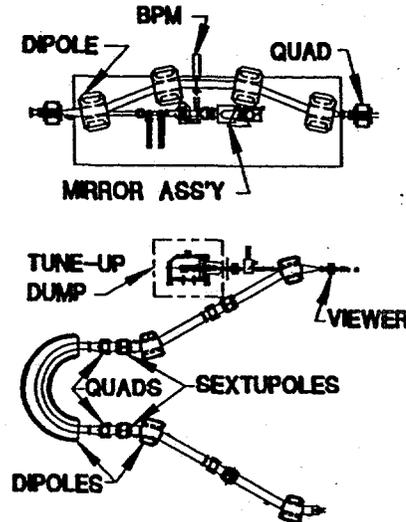


Fig. 2. Buncher chicane preceding the wiggler in Jefferson Lab's IR Demo (top), and the first recirculation bend (bottom).

### 4. Future Work

Although Paper 1 incorporates several aspects of CSR physics missing in preceding work, it also uses many simplifications. Chief among these is inherent in the "rigid-line-charge" model and the omission of the local coulomb force. It still remains to incorporate self-consistency and the three-dimensional property of the bunch. It also remains to include all of the effects of both the global CSR and local coulomb forces on the bunch dynamics, as well as to assess possible correlations between the bending magnets. We are currently exploring these intricacies in an effort to generalize the theory. We are also allowing for instrumentation in the IRFEL recirculation bend for emittance measurements to support beam-bending experiments.

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